Name: Id#

## COE 360, Principles of VLSI Design, Term 011 Ouiz# 1

Date: Saturday, Sep. 22, 2001

- Q1. Indicate whether the following is true or false, and if it is false **correct** it:
  - (1) (**True, False**) If an intrinsic semiconductor material is doped with n-type impurities, the number of free electrons increases while the number of free holes remains the same.
  - (2) (**True, False**) To maintain the electric neutrality of the crystal, the number of free electrons  $n = p + N_A N_D$ .
  - (3) (**True, False**) Mobility increases with temperature because more carriers are present and these carriers are more energetic at higher temperatures.
  - (4) (True, False) Further diffusion of majority carriers across a pn junction is stopped due to the balance of concentration of majority carriers across the junction.
  - (5) (**True, False**) In general, higher doping concentrations result in lower depletion region width and lower transition capacitance.
  - (6) (**True, False**) The width of the depletion region in a forward-biased pn junction is narrower than that of a reverse-biased pn junction.
  - (7) (True, False)  $V_{OH}$  is the output voltage produced when the input voltage is less than or equal to  $V_{IL}$ .

- (8) (True, False) A piece of semiconductor material which is doped with equal donor and acceptor impurity concentrations has higher conductivity compared to the intrinsic semiconductor since it has higher electron and hole concentrations.
- (9) (True, False) It is desirable to have  $V_{IL}$  as large as possible and  $V_{IH}$  as small as possible to increase the noise margins.
- (10) (True, False) The fanout of a gate with  $V_{IL}$ =1.2V,  $V_{IH}$ =2.4V,  $V_{OH}$ =4.8V,  $V_{OL}$ =0.2,  $I_{IH}$ =60 $\mu$ A,  $I_{IL}$ =4.8mA,  $I_{OH}$ =360 $\mu$ A, and  $I_{OL}$ =24mA is 5.
- **Q2.** An intrinsic silicon bar is 8 mm long and has a rectangular cross section of 40X80  $\mu$ m. The material has a resistivity of 100K  $\Omega$ .cm. Determine the following:
  - (i) The concentration of Arsenic atoms needed to be added to the material to convert it to an n-type material with a resistivity of 20  $\Omega$ .cm.
  - (ii) Determine the voltage across the intrinsic silicon bar when a steady current of 5  $\mu A$  is measured.

Assume the following: Electron mobility at 300 K=1500 cm<sup>2</sup>/V.s, Hole mobility at 300 K = 475 cm<sup>2</sup>/V.s,  $q=1.6X10^{-19}$